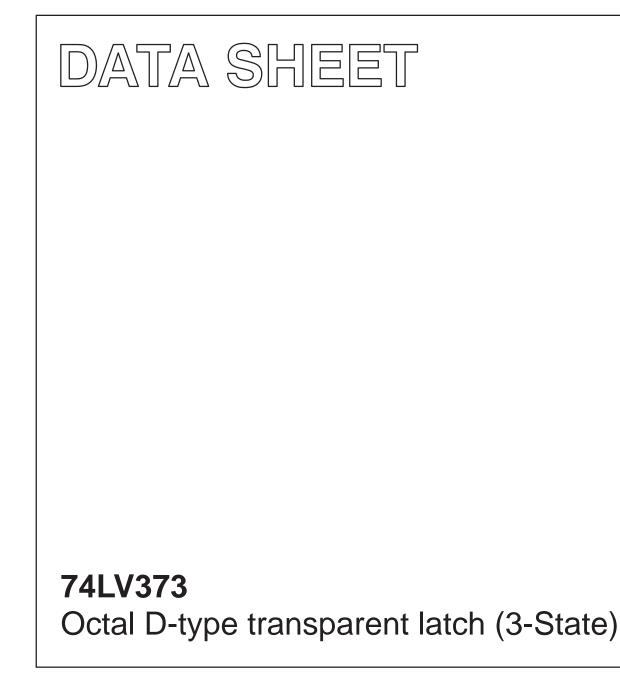
# INTEGRATED CIRCUITS



Product specification Supersedes data of 1997 March 04 IC24 Data Handbook

1998 Jun 10



Philips Semiconductors

### 74LV373

#### **FEATURES**

- Wide operating voltage: 1.0 to 5.5V
- Optimized for Low Voltage applications: 1.0V to 3.6V
- Accepts TTL input levels between  $V_{CC}$  = 2.7V and  $V_{CC}$  = 3.6V
- Typical V<sub>OLP</sub> (output ground bounce) < 0.8V at V<sub>CC</sub> = 3.3V,  $T_{amb} = 25^{\circ}C$
- Typical V<sub>OHV</sub> (output V<sub>OH</sub> undershoot) > 2V at V<sub>CC</sub> = 3.3V, T<sub>amb</sub> = 25°C
- Common 3-State output enable input
- Output capability: bus driver
- I<sub>CC</sub> category: MSI

#### DESCRIPTION

The 74LV373 is a low-voltage Si-gate CMOS device that is pin and function compatible with 74HC/HCT373.

The 74LV373 is an octal D-type transparent latch featuring separate D-type inputs for each latch and 3-State outputs for bus oriented applications. A latch enable (LE) input and an output enable ( $\overline{OE}$ ) input are common to all internal latches.

The '373' consists of eight D-type transparent latches with 3-State true outputs. When LE is HIGH, data at the Dn inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change each time its corresponding D-input changes.

When LE is LOW the latches store the information that was present at the D-inputs a set-up time preceding the HIGH-to-LOW transition of LE. When  $\overline{OE}$  is LOW, the contents of the eight latches are available at the outputs. When  $\overline{OE}$  is HIGH, the outputs go to the high impedance OFF-state. Operation of the  $\overline{OE}$  input does not affect the state of the latches.

The '373' is functionally identical to the '573', but the '573' has a different pin arrangement.

#### QUICK REFERENCE DATA

#### GND = 0V; $T_{amb} = 25^{\circ}C$ ; $t_r = t_f \le 2.5$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay D <sub>n</sub> to Q <sub>n</sub> LE to Q <sub>n</sub>	$C_L = 15 pF$ $V_{CC} = 3.3V$	10 12	ns
Cl	Input capacitance		3.5	pF
C <sub>PD</sub>	Power dissipation capacitance per latch	Notes 1, 2	22	pF

NOTES:

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu$ W)  $P_D = C_{PD} \times V_{CC}^2 x f_i + \sum (C_L \times V_{CC}^2 \times f_o)$  where:  $f_i$  = input frequency in MHz;  $C_L$  = output load capacity in pF;  $f_o$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;  $\sum (C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.

2. The condition is  $V_I = GND$  to  $V_{CC}$ .

#### **ORDERING AND PACKAGE INFORMATION**

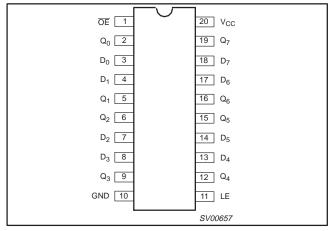
PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
20-Pin Plastic DIL	–40°C to +125°C	74LV373 N	74LV373 N	SOT146-1
20-Pin Plastic SO	–40°C to +125°C	74LV373 D	74LV373 D	SOT163-1
20-Pin Plastic SSOP Type II	–40°C to +125°C	74LV373 DB	74LV373 DB	SOT339-1
20-Pin Plastic TSSOP Type I	–40°C to +125°C	74LV373 PW	74LV373PW DH	SOT360-1

#### **PIN DESCRIPTION**

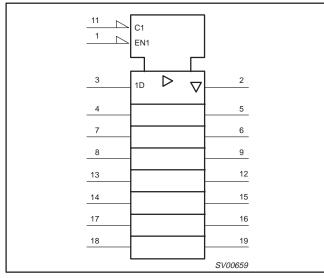
PIN NUMBER	SYMBOL	FUNCTION
1	ŌĒ	Output enabled input (active LOW)
2, 5, 6, 9, 12, 15, 16, 19	Q <sub>0</sub> –Q <sub>7</sub>	3-State latch outputs
3, 4, 7, 8, 13, 14, 17, 18	D <sub>0</sub> –D <sub>7</sub>	Data inputs
10	GND	Ground (0V)
11	LE	Latch enable input (active HIGH)
20	V <sub>CC</sub>	Positive supply voltage

## 74LV373

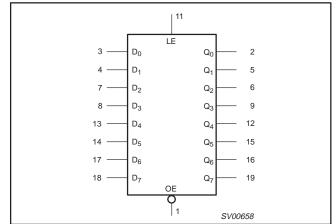
#### **PIN CONFIGURATION**



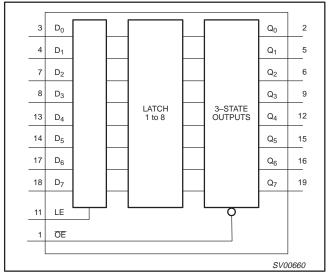
#### LOGIC SYMBOL (IEEE/IEC)



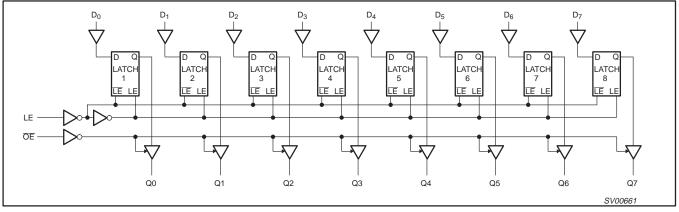
#### LOGIC SYMBOL



### FUNCTIONAL DIAGRAM



### LOGIC DIAGRAM



Product specification

#### **FUNCTION TABLE**

OPERATING MODES		INPUTS		INTERNAL	OUTPUTS
OPERATING MODES	ŌĒ	LE	Dn	LATCHES	Q <sub>0</sub> to Q <sub>7</sub>
Enable and read register (transparent mode)	L L	н н	L H	L H	L H
Latch and read register	L L	L	l h	L H	L H
Latch register and disable outputs	H H	L L	l h	L H	Z Z

H = HIGH voltage level

h = HIGH voltage level one set-up time prior to the HIGH-to-LOW LE transition

L = LOW voltage level

I = LOW voltage level one set-up time prior to the HIGH-to-LOW LE transition

X = Don't care

Z = High impedance OFF-state

#### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
V <sub>CC</sub>	DC supply voltage	See Note1	1.0	3.3	5.5	V
VI	Input voltage		0	-	V <sub>CC</sub>	V
Vo	Output voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	Operating ambient temperature range in free air	See DC and AC characteristics	-40 -40		+85 +125	°C
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	$\begin{array}{l} V_{CC} = 1.0V \mbox{ to } 2.0V \\ V_{CC} = 2.0V \mbox{ to } 2.7V \\ V_{CC} = 2.7V \mbox{ to } 3.6V \\ V_{CC} = 3.6V \mbox{ to } 5.5V \end{array}$			500 200 100 50	ns/V

NOTE:

1. The LV is guaranteed to function down to  $V_{CC}$  = 1.0V (input levels GND or  $V_{CC}$ ); DC characteristics are guaranteed from  $V_{CC}$  = 1.2V to  $V_{CC}$  = 5.5V.

#### ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

In accordance with the Absolute Maximum Rating System (IEC 134).

Voltages are referenced to GND (ground = 0V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V
±I <sub>IK</sub>	DC input diode current	$V_{I} < -0.5 \text{ or } V_{I} > V_{CC} + 0.5 V$	20	mA
±Ι <sub>ΟΚ</sub>	DC output diode current	$V_{O}$ < -0.5 or $V_{O}$ > $V_{CC}$ + 0.5V	50	mA
±ΙΟ	DC output source or sink current – bus driver outputs	$-0.5V < V_{O} < V_{CC} + 0.5V$	35	mA
±I <sub>GND</sub> , ±I <sub>CC</sub>	DC V <sub>CC</sub> or GND current for types with –bus driver outputs		70	mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C
P <sub>tot</sub>	Power dissipation per package –plastic DIL –plastic mini-pack (SO) –plastic shrink mini-pack (SSOP and TSSOP)	for temperature range: -40 to +125°C above +70°C derate linearly with 12mW/K above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	750 500 400	mW

NOTES:

1998 Jun 10

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### DC CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0V).

			LIMITS						
SYMBOL	PARAMETER	TEST CONDITIONS	-40	)°C to +8	5°C	-40°C to	o +125°C		
			MIN	TYP <sup>1</sup>	MAX	MIN	MAX		
		$V_{CC} = 1.2V$	0.9			0.9			
VIH	HIGH level Input	$V_{CC} = 2.0 V$	1.4			1.4			
VIH voltage	voltage	V <sub>CC</sub> = 2.7 to 3.6V	2.0			2.0		Ň	
		$V_{CC} = 4.5$ to 5.5V	0.7*V <sub>CC</sub>			0.7*V <sub>CC</sub>			
		$V_{CC} = 1.2V$			0.3		0.3		
V	LOW level Input	$V_{CC} = 2.0V$			0.6		0.6		
V <sub>IL</sub>	voltage	V <sub>CC</sub> = 2.7 to 3.6V			0.8		0.8	ľ	
		V <sub>CC</sub> = 4.5 to 5.5			0.3*V <sub>CC</sub>		0.3*V <sub>CC</sub>	1	
		$V_{CC} = 1.2V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 100 \mu A$		1.2					
V <sub>OH</sub> HIGH level output V <sub>OH</sub>	$V_{CC} = 2.0V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 100 \mu A$	1.8	2.0		1.8		1		
	$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 100 \mu A$	2.5	2.7		2.5		]		
	voltago, an outputo	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 100 \mu A$	2.8	3.0		2.8		v	
		$V_{CC} = 4.5V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 100 \mu A$	4.3	4.5		4.3		1	
	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} - I_O = 8mA$	2.40	2.82		2.20				
	voltage; BUS driver outputs	$V_{CC} = 4.5V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $-I_O = 16mA$	3.60	4.20		3.50		1	
		$V_{CC} = 1.2V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		0					
		$V_{CC} = 2.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		0	0.2		0.2	1	
	LOW level output voltage; all outputs	$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		0	0.2		0.2	1	
V <sub>OL</sub>	voltage, all outputs	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		0	0.2		0.2		
- OL		$V_{CC} = 4.5V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$		0	0.2		0.2	1	
	LOW level output	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} I_O = 8mA$		0.20	0.40		0.50	1	
	voltage; BUS driver outputs	$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $I_{O}$ = 16mA		0.35	0.55		0.65	1	
I	Input leakage current	$V_{CC} = 5.5V; V_1 = V_{CC} \text{ or GND}$			1.0		1.0	μA	
I <sub>OZ</sub>	3-State output OFF-state current	$V_{CC} = 5.5$ V; $V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND			5		10	μ/	
I <sub>CC</sub>	Quiescent supply current; MSI	$V_{CC} = 5.5V; V_1 = V_{CC} \text{ or GND}; I_0 = 0$			20.0		160	μA	
$\Delta I_{CC}$	Additional quiescent supply current per input	$V_{CC} = 2.7V$ to 3.6V; $V_{I} = V_{CC} - 0.6V$			500		850	μ/	

NOTE:

1. All typical values are measured at  $T_{amb} = 25^{\circ}C$ .

#### **AC CHARACTERISTICS**

 $\text{GND} = \text{OV}; \ t_{\text{f}} = t_{\text{f}} \leq 2.5 \text{ns}; \ \text{C}_{\text{L}} = 50 \text{pF}; \ \text{R}_{\text{L}} = 1 \text{K} \Omega$ 

			CONDITION			LIMITS			
SYMBOL	PARAMETER	WAVEFORM	CONDITION	-	40 to +85 °	С	-40 to	+125 °C	UNIT
			V <sub>CC</sub> (V)	MIN	TYP <sup>1</sup>	MAX	MIN	MAX	
			1.2	-	65	-	-	-	
	t <sub>PHL/</sub> t <sub>PLH</sub> Propagation delay D <sub>n</sub> to Q <sub>n</sub>		2.0	-	22	37	-	48	
t <sub>PHL</sub> /t <sub>PLH</sub>		Figure 1, 5	2.7	-	16	28	-	35	ns
	11		3.0 to 3.6	-	13 <sup>2</sup>	22	-	28	
			4.5 to 5.5	-	-	16	-	20	
		1.2	-	80	-	-	-		
			2.0	-	27	43	-	54	
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay LE to Q <sub>n</sub>	Figure 2, 5	2.7	-	20	26	-	33	ns
		3.0 to 3.6	-	15 <sup>2</sup>	25	-	31		
		4.5 to 5.5	-	9.5 <sup>3</sup>	19	-	24		
3-State output		1.2	-	80	-	-	-		
		2.0	-	27	46	-	58		
t <sub>PZH</sub> /t <sub>PZL</sub>	enable time	Figure 3	2.7	-	20	28	-	35	ns
	OE to Q <sub>n</sub>		3.0 to 3.6	-	15 <sup>2</sup>	27	-	34	
			4.5 to 5.5	-	-	23	-	29	
			1.2	-	75	-	-	-	ns
	3-State output	Figure 3	2.0	-	27	46	-	58	
t <sub>PHZ</sub> /t <sub>PLZ</sub>	disable time		2.7	-	21	28	-	35	
	OE to Q <sub>n</sub>		3.0 to 3.6	-	16 <sup>2</sup>	27	-	34	
			4.5 to 5.5	-	-	23	-	29	
			2.0	34	10	-	41	-	
t <sub>W</sub>	LE pulse width HIGH	Figure 2	2.7	25	8	-	30	-	ns
			3.0 to 3.6	20	6 <sup>2</sup>	-	24	-	
			1.2	-	25	-	-	-	
	Setup time D <sub>n</sub> to LE	Figure 4	2.0	17	9	-	20	-	20
t <sub>su</sub>		Figure 4	2.7	13	6	-	15	-	ns
			3.0 to 3.6	10	5 <sup>2</sup>	-	12	-	
			1.2	-	-15	-	-	-	
+.	Hold time D <sub>n</sub> to LE	Figure 4	2.0	5	-5	-	5	-	
t <sub>h</sub>	noid line D <sub>n</sub> to LE	Figure 4	2.7	5	-3	-	5	-	ns
			3.0 to 3.6	5	-3 <sup>2</sup>	-	5	-	

NOTES:

1. All typical values are measured at  $T_{amb} = 25^{\circ}C$ 2. Typical values are measured at  $V_{CC} = 3.3V$ 3. Typical values are measured at  $V_{CC} = 5.0V$ 

### 74LV373

#### **AC WAVEFORMS**

 $\begin{array}{l} \mathsf{V}_{M}=1.5\mathsf{V} \text{ at } \mathsf{V}_{CC} \geq 2.7\mathsf{V} \text{ and } \leq 3.6\mathsf{V} \\ \mathsf{V}_{M}=0.5\mathsf{V} * \mathsf{V}_{CC} \text{ at } \mathsf{V}_{CC} < 2.7\mathsf{V} \text{ and } \geq 4.5\mathsf{V} \\ \mathsf{V}_{OL} \text{ and } \mathsf{V}_{OH} \text{ are the typical output voltage drop that occur with the output load.} \\ \mathsf{V}_{X}=\mathsf{V}_{OL}+0.3\mathsf{V} \text{ at } \mathsf{V}_{CC} \geq 2.7\mathsf{V} \text{ and } \leq 3.6\mathsf{V} \\ \mathsf{V}_{X}=\mathsf{V}_{OL}+0.1\mathsf{V}_{CC} \text{ at } \mathsf{V}_{CC} < 2.7\mathsf{V} \text{ and } \geq 4.5\mathsf{V} \\ \mathsf{V}_{Y}=\mathsf{V}_{OH}-0.3\mathsf{V} \text{ at } \mathsf{V}_{CC} \geq 2.7\mathsf{V} \text{ and } \geq 4.5\mathsf{V} \\ \mathsf{V}_{Y}=\mathsf{V}_{OH}-0.3\mathsf{V} \text{ at } \mathsf{V}_{CC} \geq 2.7\mathsf{V} \text{ and } \leq 3.6\mathsf{V} \end{array}$ 

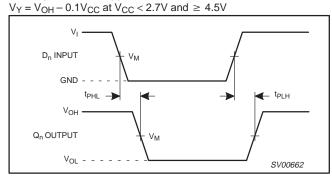


Figure 1. Data input  $(D_n)$  to output  $(Q_n)$  propagation delays and the output transition times.

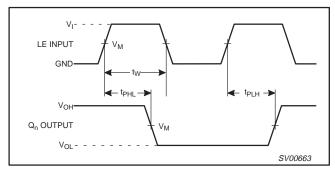


Figure 2. Latch enable input (LE) pulse width, the latch enable input to output  $(Q_n)$  propagation delays and the output transition times.

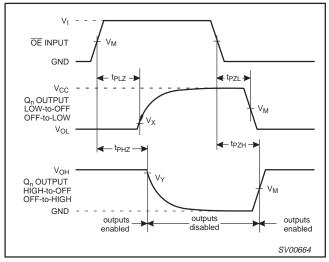


Figure 3. 3-State enable and disable times.

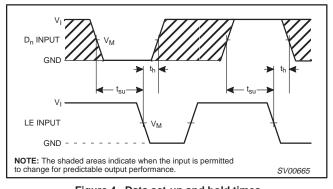
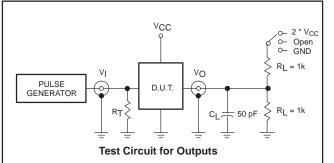


Figure 4. Data set-up and hold times for the D<sub>n</sub> input to the LE input.

#### **TEST CIRCUIT**



#### DEFINITIONS

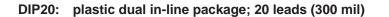
 $R_L$  = Load resistor  $C_L$  = Load capacitance includes jig and probe capacitiance.

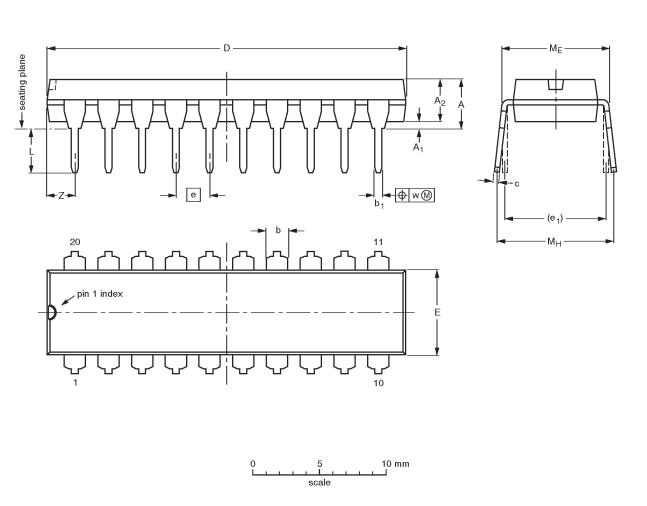
 $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

#### SWITCH POSITION

t <sub>PLH/</sub> t <sub>PHL</sub> Open < 2.7V V <sub>CC</sub>
t <sub>PLZ</sub> /t <sub>PZL</sub> 2 * V <sub>CC</sub> 2.7–3.6V 2.7V
$t_{PHZ/t_{PZH}}$ GND $\geq 4.5V$ V <sub>CC</sub>

Figure 5. Load circuitry for switching times





#### DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	с	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

#### Note

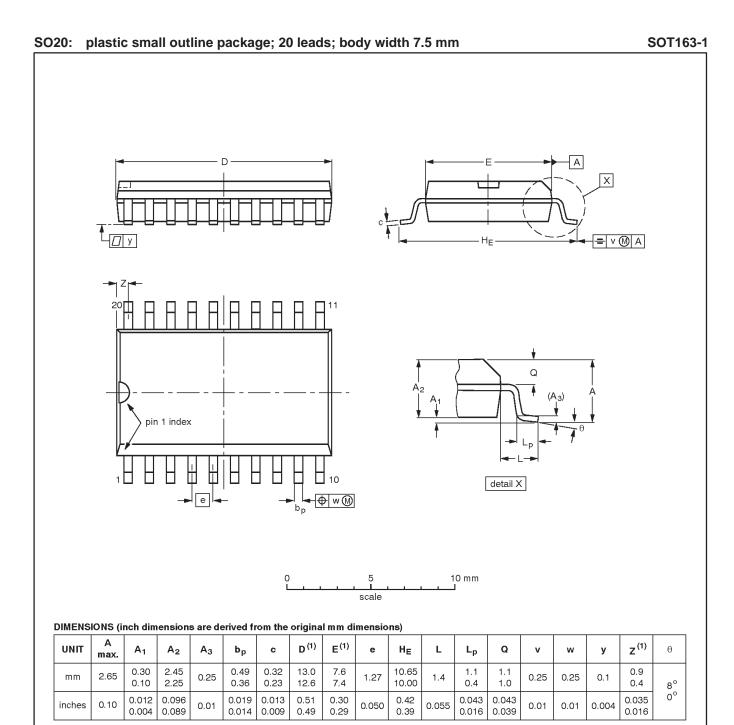
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1550E DATE	
SOT146-1			SC603		<del>-92-11-17</del> 95-05-24	

# Product specification

74LV373

### 74LV373

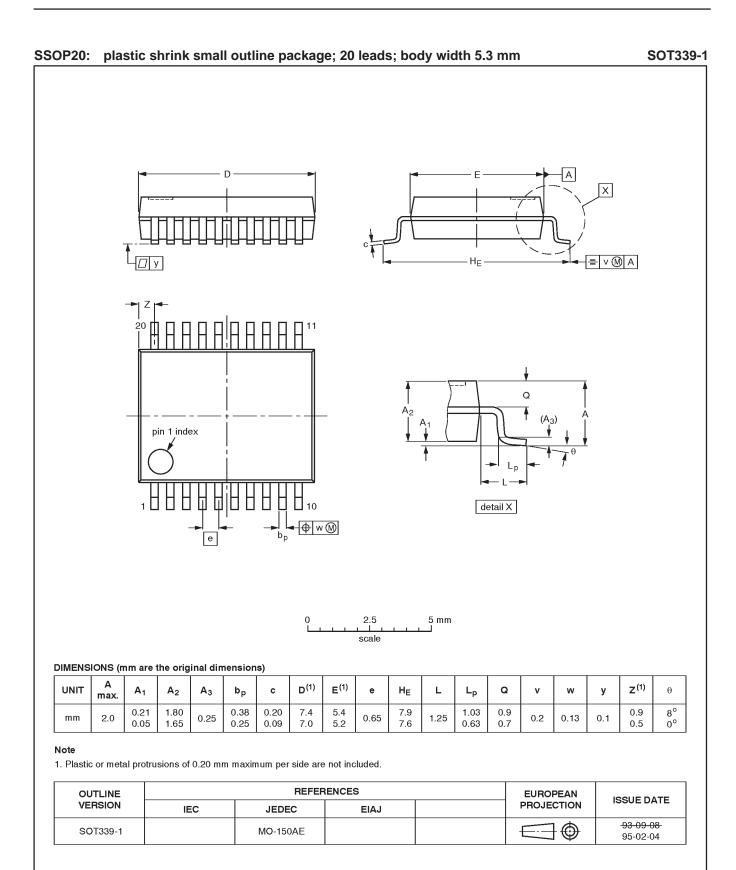


#### Note

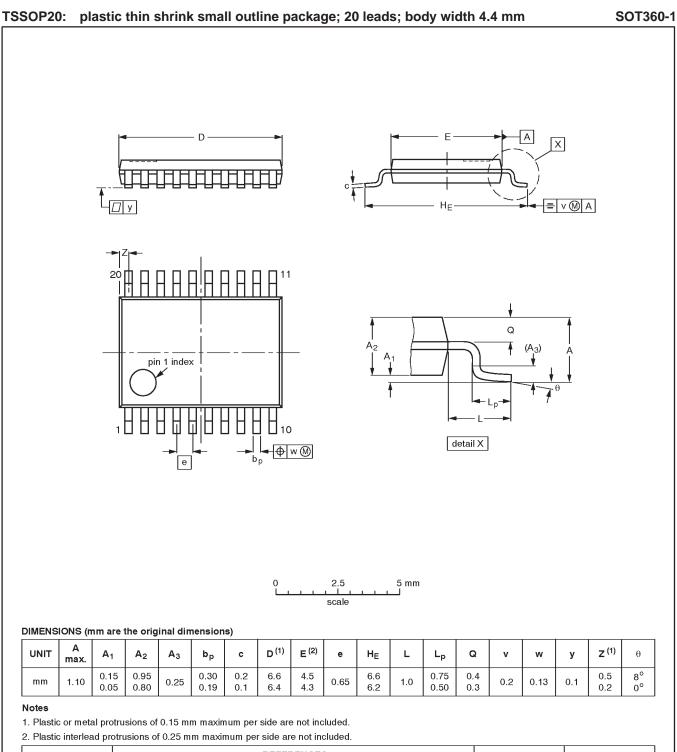
1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT163-1	075E04	MS-013AC			<del>-92-11-17</del> 95-01-24	

74LV373



74LV373



OUTLINE VERSION	REFERENCES				EUROPEAN	ISSUE DATE
	IEC	JEDEC	EIAJ		PROJECTION	ISSUEDATE
SOT360-1		MO-153AC				<del>-93-06-16</del> 95-02-04

## 74LV373

DEFINITIONS						
Data Sheet Identification	Product Status	Definition				
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.				
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.				
Product Specification	Full Production	This data sheet contains Final Specifications. Philips Semiconductors reserves the right to make changes at any time without notice, in order to improve design and supply the best possible product.				

Philips Semiconductors and Philips Electronics North America Corporation reserve the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified. Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

#### LIFE SUPPORT APPLICATIONS

Philips Semiconductors and Philips Electronics North America Corporation Products are not designed for use in life support appliances, devices, or systems where malfunction of a Philips Semiconductors and Philips Electronics North America Corporation Product can reasonably be expected to result in a personal injury. Philips Semiconductors and Philips Electronics North America Corporation customers using or selling Philips Semiconductors and Philips Electronics North America Corporation customers using or selling Philips Semiconductors and Philips Electronics North America Corporation so at their own risk and agree to fully indemnify Philips Semiconductors and Philips Electronics North America Corporation for any damages resulting from such improper use or sale.

Philips Semiconductors 811 East Arques Avenue P.O. Box 3409 Sunnyvale, California 94088–3409 Telephone 800-234-7381 © Copyright Philips Electronics North America Corporation 1998 All rights reserved. Printed in U.S.A.

print code

Document order number:

Date of release: 05-96 9397-750-04447

Let's make things better.



PHILIPS